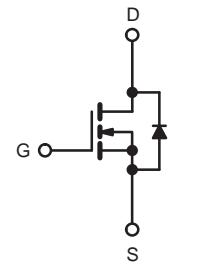
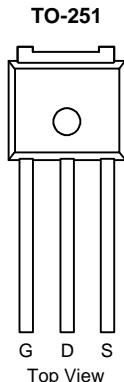


## N-Channel 650V (D-S) Power MOSFET

PRODUCT SUMMARY	
V <sub>DS</sub> (V)	650
R <sub>DS(on)</sub> ( $\Omega$ )	V <sub>GS</sub> = 10 V      2.0
Q <sub>g</sub> (Max.) (nC)	48
Q <sub>gs</sub> (nC)	12
Q <sub>gd</sub> (nC)	19
Configuration	Single

### FEATURES

- Low Gate Charge Q<sub>g</sub> Results in Simple Drive Requirement
- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Compliant to RoHS directive 2002/95/EC



ABSOLUTE MAXIMUM RATINGS T <sub>C</sub> = 25 °C, unless otherwise noted			
PARAMETER	SYMBOL	LIMIT	UNIT
Drain-Source Voltage	V <sub>DS</sub>	650	V
Gate-Source Voltage	V <sub>GS</sub>	$\pm 30$	
Continuous Drain Current <sup>e</sup>	I <sub>D</sub>	4.5	A
Continuous Drain Current		4.2	
Pulsed Drain Current <sup>a</sup>	I <sub>DM</sub>	18	
Linear Derating Factor		0.48	W/°C
Single Pulse Avalanche Energy <sup>b</sup>	E <sub>AS</sub>	325	mJ
Repetitive Avalanche Current <sup>c</sup>	I <sub>AR</sub>	4	A
Repetitive Avalanche Energy <sup>c</sup>	E <sub>AR</sub>	6	mJ
Maximum Power Dissipation	P <sub>D</sub>	60	W
Peak Diode Recovery dV/dt <sup>c</sup>	dV/dt	2.8	V/ns
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C
Soldering Recommendations (Peak Temperature) <sup>d</sup>	for 10 s	300	
Mounting Torque	6-32 or M3 screw	10	lbf · in
		1.1	N · m

### Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- Starting T<sub>J</sub> = 25 °C, L = 24 mH, R<sub>G</sub> = 25 Ω, I<sub>AS</sub> = 3.2 A (see fig. 12).
- I<sub>SD</sub> ≤ 3.2 A, dI/dt ≤ 90 A/μs, V<sub>DD</sub> ≤ V<sub>DS</sub>, T<sub>J</sub> ≤ 150 °C.
- 1.6 mm from case.
- Drain current limited by maximum junction temperature.

**THERMAL RESISTANCE RATINGS**

PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	$R_{thJA}$	-	65	$^{\circ}\text{C}/\text{W}$
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	2.1	

**SPECIFICATIONS**  $T_J = 25^{\circ}\text{C}$ , unless otherwise noted

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
<b>Static</b>						
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}$ , $I_D = 250 \mu\text{A}$	650	-	-	V
$V_{DS}$ Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to $25^{\circ}\text{C}$ , $I_D = 1 \text{ mA}^d$	-	670	-	$\text{mV}/^{\circ}\text{C}$
Gate-Source Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}$ , $I_D = 250 \mu\text{A}$	2.0	-	4.0	V
Gate-Source Leakage	$I_{GSS}$	$V_{GS} = \pm 30 \text{ V}$	-	-	$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 650 \text{ V}$ , $V_{GS} = 0 \text{ V}$	-	-	25	$\mu\text{A}$
		$V_{DS} = 520 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $T_J = 125^{\circ}\text{C}$	-	-	250	
Drain-Source On-State Resistance	$R_{DS(\text{on})}$	$V_{GS} = 10 \text{ V}$	$I_D = 3.1 \text{ A}^b$	-	-	$\Omega$
Forward Transconductance	$g_{fs}$	$V_{DS} = 50 \text{ V}$ , $I_D = 3.1 \text{ A}$	3.9	-	-	S
<b>Dynamic</b>						
Input Capacitance	$C_{iss}$	$V_{GS} = 0 \text{ V}$ , $V_{DS} = 25 \text{ V}$ , $f = 1.0 \text{ MHz}$ , see fig. 5	-	1417	-	pF
Output Capacitance	$C_{oss}$		-	177	-	
Reverse Transfer Capacitance	$C_{rss}$		-	7.0	-	
Output Capacitance	$C_{oss}$	$V_{GS} = 0 \text{ V}$	$V_{DS} = 1.0 \text{ V}$ , $f = 1.0 \text{ MHz}$	-	1912	-
			$V_{DS} = 520 \text{ V}$ , $f = 1.0 \text{ MHz}$	-	48	-
Effective Output Capacitance	$C_{oss \text{ eff.}}$		$V_{DS} = 0 \text{ V}$ to $520 \text{ V}^c$	-	84	-
Total Gate Charge	$Q_g$	$V_{GS} = 10 \text{ V}$	$I_D = 3.2 \text{ A}$ , $V_{DS} = 400 \text{ V}$ see fig. 6 and 13 <sup>b</sup>	-	-	48
Gate-Source Charge	$Q_{gs}$			-	-	12
Gate-Drain Charge	$Q_{gd}$			-	-	19
Turn-On Delay Time	$t_{d(on)}$			-	14	-
Rise Time	$t_r$	$V_{DD} = 325 \text{ V}$ , $I_D = 3.2 \text{ A}$ $R_G = 9.1 \Omega$ , $R_D = 62 \Omega$ , see fig. 10 <sup>b</sup>		-	20	-
Turn-Off Delay Time	$t_{d(off)}$			-	34	-
Fall Time	$t_f$			-	18	-
<b>Drain-Source Body Diode Characteristics</b>						
Continuous Source-Drain Diode Current	$I_S$	MOSFET symbol showing the integral reverse p - n junction diode	-	-	4	A
Pulsed Diode Forward Current <sup>a</sup>	$I_{SM}$		-	-	21	
Body Diode Voltage	$V_{SD}$	$T_J = 25^{\circ}\text{C}$ , $I_S = 3.2 \text{ A}$ , $V_{GS} = 0 \text{ V}^b$	-	-	1.5	V
Body Diode Reverse Recovery Time	$t_{rr}$	$T_J = 25^{\circ}\text{C}$ , $I_F = 3.2 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}^b$	-	493	739	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$		-	2.1	3.2	$\mu\text{C}$
Forward Turn-On Time	$t_{on}$	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )				

**Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).  
 b. Pulse width  $\leq 300 \mu\text{s}$ ; duty cycle  $\leq 2\%$ .  
 c.  $C_{oss \text{ eff.}}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .  
 d.  $t = 60 \text{ s}$ ,  $f = 60 \text{ Hz}$ .

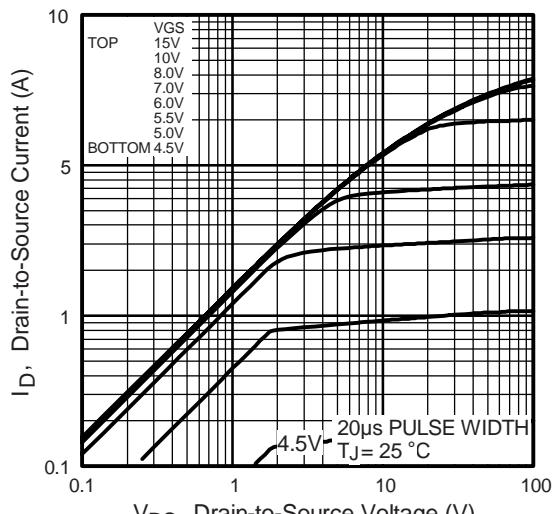
**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted


Fig. 1 - Typical Output Characteristics

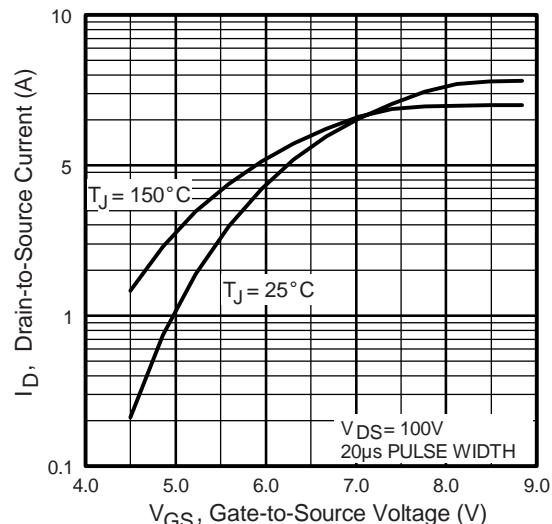


Fig. 3 - Typical Transfer Characteristics

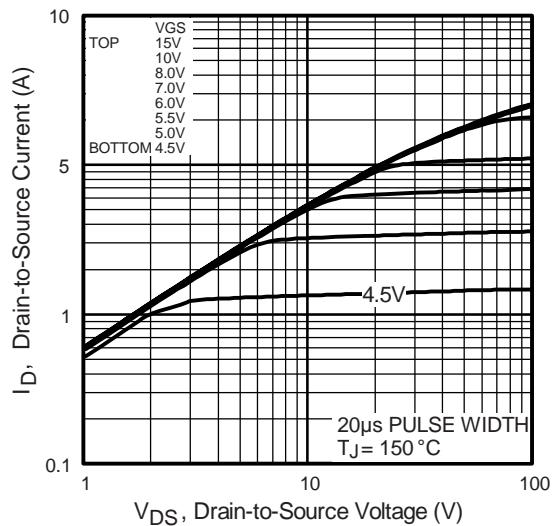


Fig. 2 - Typical Output Characteristics

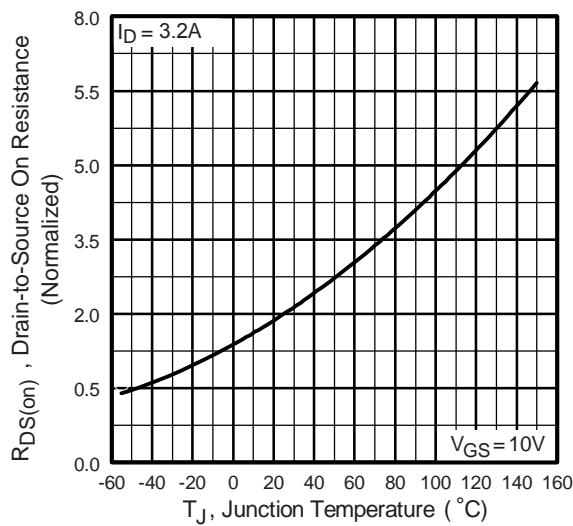


Fig. 4 - Normalized On-Resistance vs. Temperature

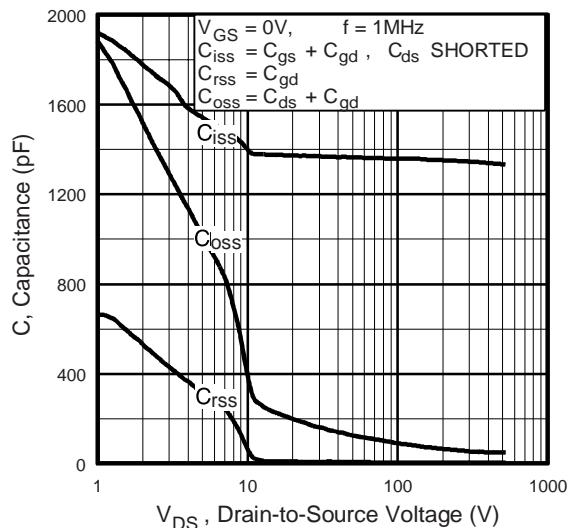


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

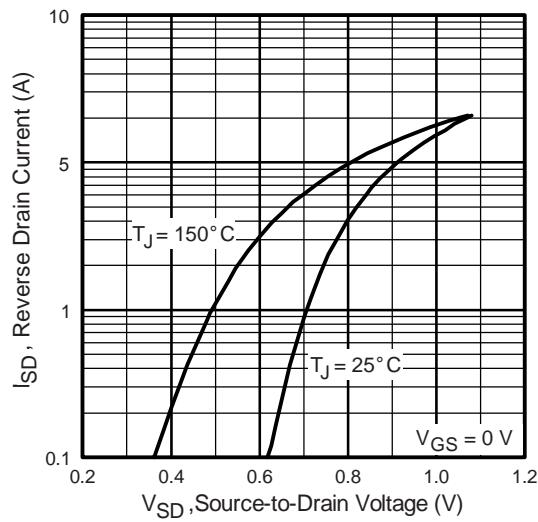


Fig. 7 - Typical Source-Drain Diode Forward Voltage

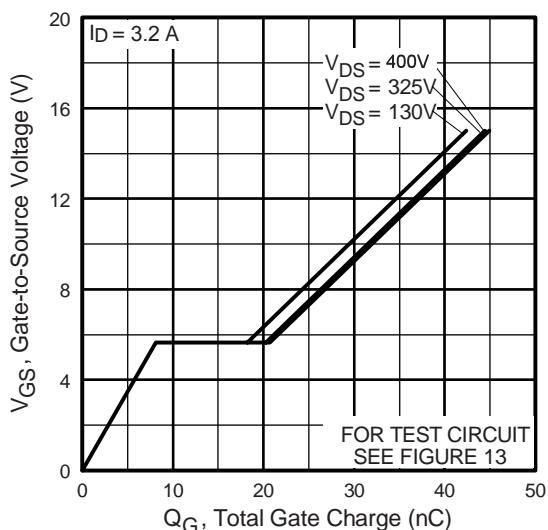


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

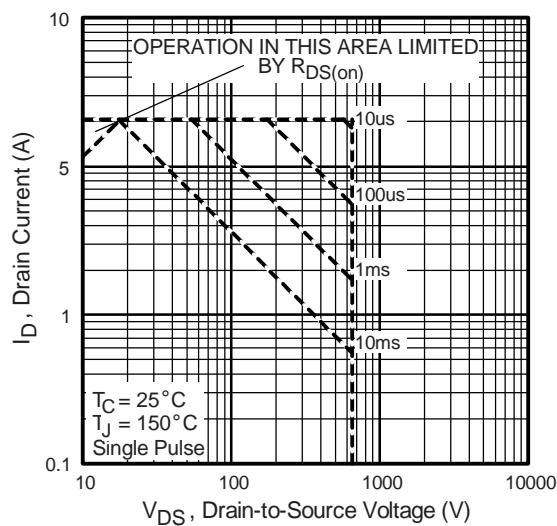


Fig. 8 - Maximum Safe Operating Area

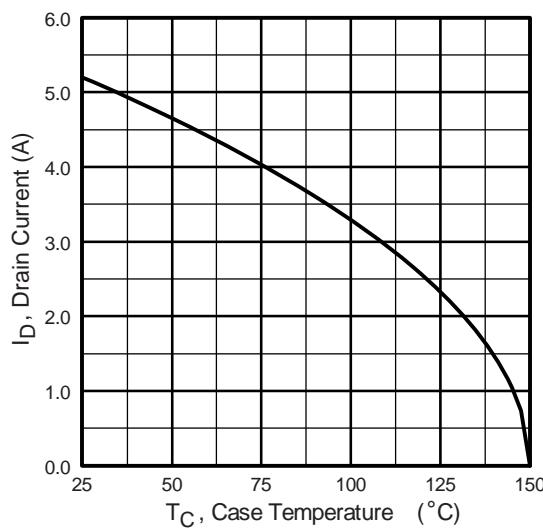


Fig. 9 - Maximum Drain Current vs. Case Temperature

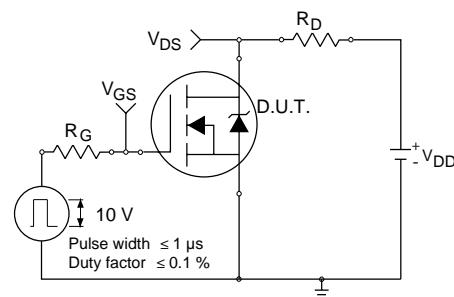


Fig. 10a - Switching Time Test Circuit

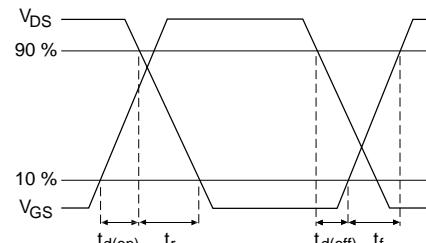


Fig. 10b - Switching Time Waveforms

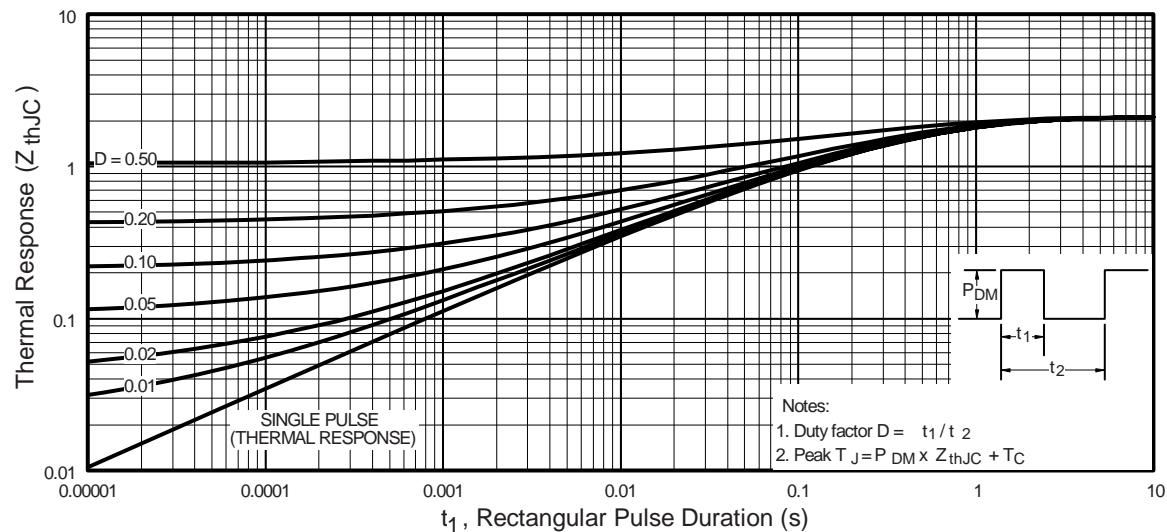


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

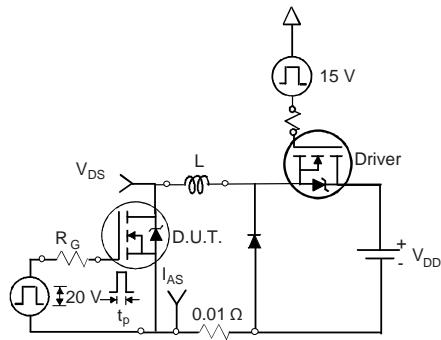


Fig. 12a - Unclamped Inductive Test Circuit

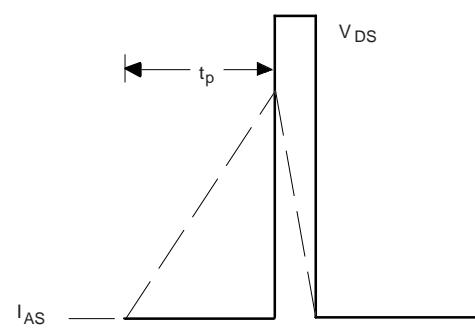


Fig. 12b - Unclamped Inductive Waveforms

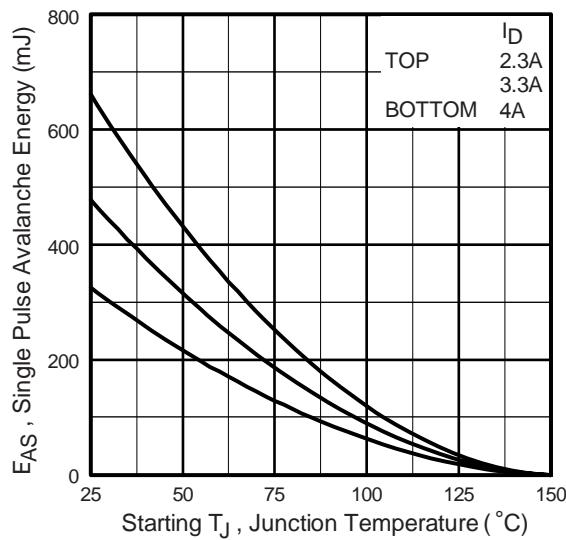


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

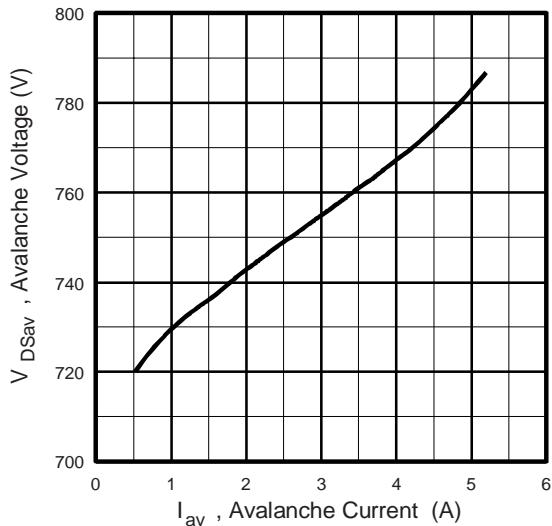


Fig. 12d - Typical Drain-to Source Voltage vs. Avalanche Current

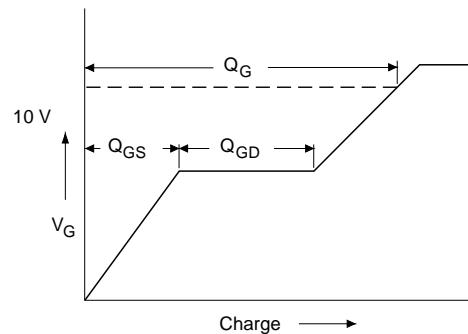


Fig. 13a - Basic Gate Charge Waveform

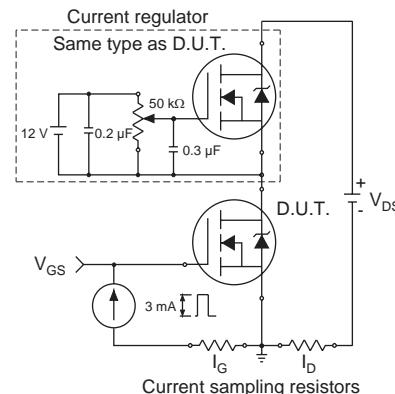
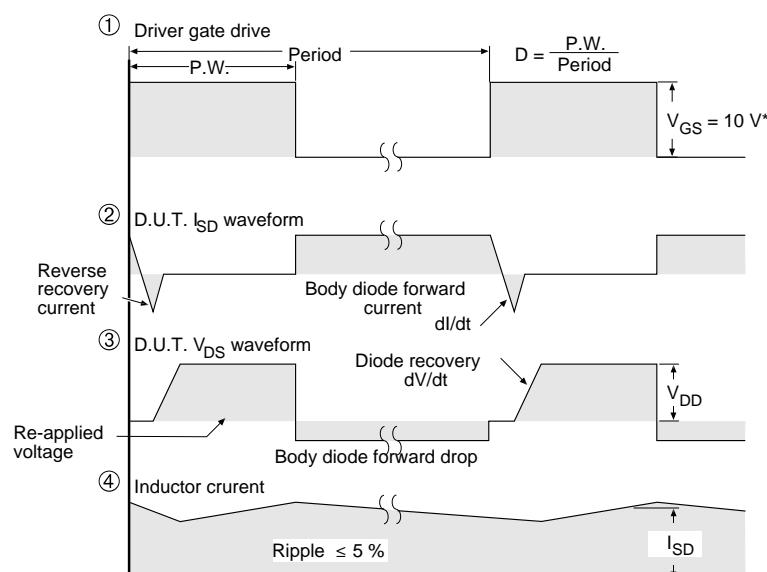
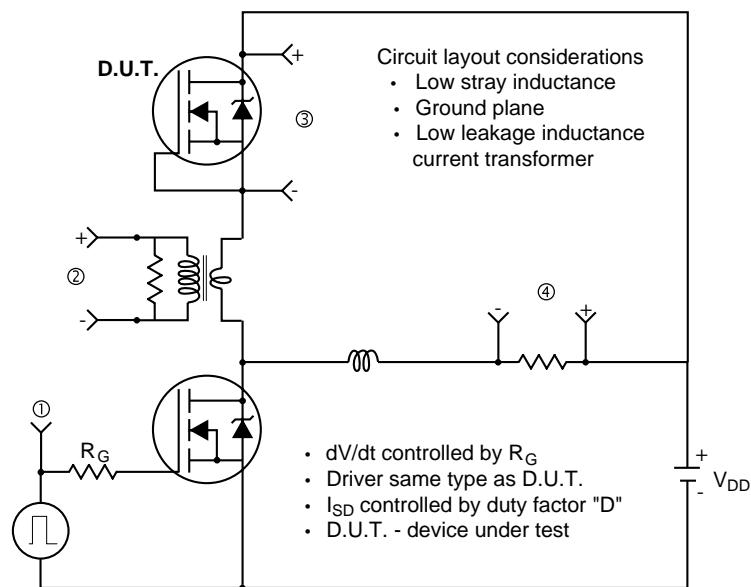


Fig. 13b - Gate Charge Test Circuit

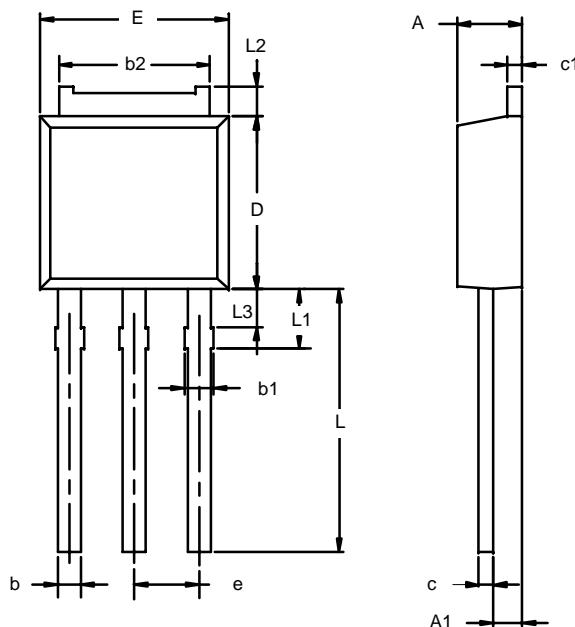
### Peak Diode Recovery $dV/dt$ Test Circuit



\*  $V_{GS} = 5 \text{ V}$  for logic level devices

Fig. 14 - For N-Channel

## TO-251AA



Dim	MILLIMETERS		INCHES	
	Min	Max	Min	Max
<b>A</b>	2.21	2.38	0.087	0.094
<b>A1</b>	0.89	1.14	0.035	0.045
<b>b</b>	0.71	0.89	0.028	0.035
<b>b1</b>	0.76	1.14	0.030	0.045
<b>b2</b>	5.23	5.43	0.206	0.214
<b>c</b>	0.46	0.58	0.018	0.023
<b>c1</b>	0.46	0.58	0.018	0.023
<b>D</b>	5.97	6.22	0.235	0.245
<b>E</b>	6.48	6.73	0.255	0.265
<b>e</b>	2.28 BSC		0.090 BSC	
<b>L</b>	3.89	9.53	0.153	0.375
<b>L1</b>	1.91	2.28	0.075	0.090
<b>L2</b>	0.89	1.27	0.035	0.050
<b>L3</b>	1.15	1.52	0.045	0.060

ECN: S-03946—Rev. E, 09-Jul-01  
 DWG: 5346

Note: Dimension L3 is for reference only.

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